

SPECIFICATION

TITLE: METHOD AND APPARATUS FOR ACCELERATING THE VERIFICATION  
OF APPLICATION SPECIFIC INTEGRATED CIRCUIT DESIGNS

BACKGROUND OF THE INVENTION

## 1. Field of the Invention

The present invention relates to verification of electronic circuit designs and more particularly to accelerating verification of current circuit design by the acceleration of software simulators and emulation of electronic designs by means of reprogrammable devices such as a Field Programmable Gate Array (FPGA). More particularly the invention can relate to the accelerated verification by automatic retargeting of Application Specific Integrated Circuits (ASIC) designs and High Definition Logic (HDL) designs in general, into reprogrammable devices of the specified kind.

## 2. Background Information

Today's ASIC designs have tens of millions of gates. To verify these designs, software simulators such as the NC-Sim from Cadence Design, VCS Simulator from Synopsys and Riviera and an Active-HDL from Aldec, Inc. of Las Vegas, Nevada may be used. However, since the number of gates in ASIC designs is growing faster than the speed of computers, there is a need to accelerate the operation of design simulators to verify these designs.

Express Mail Label Number: EV337034345US

I hereby certify that this correspondence is being deposited with the U. S. Postal Service as EXPRESS MAIL, postage prepaid, under 37 CFR 1.10 in an envelope addressed to the Commissioner of Patents, P. O. Box 1450, Alexandria, VA 22313-1450.

Date: October 14, 2003

By: 

David O. Berntz, Reg. No. 26,102

1       One approach is to simulate at higher levels of abstraction  
2       such as the simulator by SystemC, Behavioral VHDL, or  
3       SystemVerilog. However, these simulators require sophistication  
4       and costly compilers that are still under development, and their  
5       performance gains are not sufficient for efficient verification  
6       of the newest and largest ASIC devices.

7       Another approach is to accelerate the existing software  
8       simulators or use emulation in place of simulation altogether.  
9       Such accelerators and emulators, based on reprogrammable  
10       devices, have been manufactured by Quickturn, Inc. and Ikos,  
11       Inc. Their major drawback is that in order to reproduce basic  
12       design behavior in reprogrammable devices, hundreds of  
13       engineering hours must be spent on manual conversion of ASIC  
14       clocking chains into clocking chains running in the FPGA  
15       devices.

16       The power dissipation has become such an enormous problem  
17       in the large ASIC design devices that they employ as many as 20  
18       or 40 clocks instead of one system clock that synchronizes all  
19       data transfers between flip-flops and latches. Since gates and  
20       their interconnections in reprogrammable devices have different  
21       timings from gates and interconnection in the ASIC design, an  
22       enormous amount of mental effort and time is needed to assure  
23       reliable conversion of ASIC designs into reprogrammable devices  
24       so they can emulate ASIC design behavior. The purpose of the  
25       present invention is to insure automatic conversion of ASIC

1 designs into reprogrammable devices.

2 It is therefore one object of the present invention to  
3 accelerate the verification of new, very large ASIC designs.

4 Yet another object of the present invention is to provide a  
5 system and apparatus for accelerating the verification of very  
6 large ASIC designs by accelerating the simulation of the  
7 designs.

8 It is one object of the present invention to provide  
9 automatic conversion of ASIC designs into reprogrammable devices  
10 for quick, functional verification of the designs. This is  
11 accomplished by automatic conversion of ASIC clocking chains  
12 into clocking chains in reprogrammable devices so that these  
13 devices will behave functionally the same as the ASIC device.

14 Furthermore, another object of the present invention is to  
15 handle clocking of various flip-flops and latches, so that a  
16 wide variety of ASIC designs can be handled effectively and  
17 effortlessly by hardware accelerators, emulators and various  
18 ASIC prototyping equipment.

19 Still another object of the present invention is to provide  
20 a system and apparatus for accelerating the verification of very  
21 large ASIC designs by finding synchronous primitives in a  
22 circuit design files that are receiving clock signals from a  
23 clock source and inserting edge detectors such as between the  
24 clock sources and the synchronous primitives.

25 Yet another object of the present invention is to provide a

1 method and apparatus for accelerating the verification of ASIC  
2 designs by finding synchronous primitives that do not have a  
3 clock enable input and replacing them with a synchronous  
4 primitive having a clock enable input.

5 Still another object of the present invention is to provide  
6 a method and apparatus for verification of ASIC designs  
7 including design verification managing software that analyzes  
8 connection between inputs of synchronous primitives and outputs  
9 from asynchronous primitives and insertion of a data buffer  
10 between these inputs.

11 Still another object of the present invention is to provide  
12 a method and apparatus for verification of ASIC designs in which  
13 the verification manager software finds falling-edge clocked  
14 primitives and substitutes rising clock-edge primitives for the  
15 falling clock-edge primitives.

16 Yet another object of the present invention is to provide  
17 an apparatus and method for verification of very large ASIC  
18 designs in which design verification manager software includes  
19 memory for storing ASIC designed files, design verification  
20 manager software for processing the design files and simulator  
21 software for simulating the design files or selected parts  
22 thereof.

23 Yet another object of the present invention is to provide a  
24 method and apparatus for accelerating the verification of ASIC  
25 designs having a computer for storing design files, design

1 verification manager software, simulation software and test  
2 bench files for stimulating simulator operations and a hardware  
3 accelerator. The design verification manager software splits  
4 design files into selected simulation files and hardware  
5 execution files that are downloaded into selected simulation  
6 files in said simulator and into selected hardware execution  
7 files in said hardware accelerator.

#### 8 BRIEF DESCRIPTION OF THE INVENTION

9 The purpose of the present invention is an improved method  
10 and apparatus that will greatly accelerate the simulation and  
11 verification of ASICs. The invention disclosed herein is a  
12 complete ASIC design verification method and apparatus in an  
13 environment comprised of a simulator and hardware accelerator.  
14 Some ASIC design sections are assigned to software simulator and  
15 some to hardware accelerator. Yet all design sections operate  
16 as one unit because both simulator and accelerator are tightly  
17 interconnected through signal lines.

18 The ASCII design data is entered through a keyboard, mouse  
19 device or any other data entry device. The design can also be  
20 prepared offline on another computer employing the same  
21 arrangement as in Figure 1 and thus falling within the scope of  
22 this invention. The newly created ASIC design files are stored  
23 temporarily in Random Access Memory (RAM) and permanently on  
24 computer hard disk.

25 The data entry device are also used to set up the

1 communications link between the simulator and accelerator. The  
2 set-up affects an Input/Output (I/O) control program subroutine  
3 located in a design verification manager (DVM), which controls  
4 the flow of data between the design simulator and hardware  
5 accelerator. As part of that setup, the user may indicate to  
6 the DVM, which simulator and accelerator test points will be  
7 observed, and which simulator signal data will stimulate which  
8 accelerator test points, and vice versa.

9       Since there are typically hundreds of signals running  
10 between design sections in a simulator and target hardware, a  
11 buffer is needed for storing all signals going in each direction  
12 and applying them to the simulator and/or target hardware at the  
13 appropriate time. Because the transfer of signal data between  
14 simulator and hardware accelerator takes place over a 32-bit  
15 Peripheral Component Interface (PCI), all data are also  
16 partitioned into 32-bit data segments. Should a 64-bit PCI be  
17 used, a 64-bit partition preferably should be used. The data  
18 can also be sent over a Uniform Serial Bus (USB) or Ethernet bus  
19 or other buses as well. The buffer that stores signals going  
20 from the target hardware to the simulator is called the input  
21 signal buffer. For example, if the target hardware is supplying  
22 80 signals to a simulator three (3) 32-bit words will typically  
23 be used in the input buffer. Similarly, if a simulator is  
24 providing 100 signals to the target hardware, a set of four (4)  
25 32-bit registers will be used in the output buffer. Because the

1 hardware accelerator requires simultaneous application of all  
2 signals, two sets of buffers are needed in the output buffer.  
3 The first set of buffers, called temporary buffers, collects  
4 data sent from the simulator, and when all signals for a  
5 selected test vector have been stored in that buffer, they are  
6 transferred on a single clock edge into the "driver" buffer that  
7 drives directly the target hardware.

8 The input signal buffer feeds target hardware generated  
9 signals to the design simulator. The design simulator can also  
10 trigger an I/O program subroutine to transfer signal data from  
11 memory locations being under simulator control to the  
12 appropriate channels within the output signal buffer that  
13 controls the hardware accelerator. The output signal buffer  
14 provides data to the target hardware through a plurality of  
15 lines. This data transfer is triggered by completion of a  
16 simulation cycle.

17 If the target hardware includes a processor it should  
18 generate an interrupt that directs the simulator to read data  
19 from input buffer. A signal scan technique can also be used in  
20 place of an interrupt but it is not recommended because it is  
21 slower. If the target hardware does not include a processor,  
22 the reading from the input buffer is taking place at a  
23 predetermined timeout that is needed for target hardware to  
24 reach its steady state after any signal transition on its input.

25 Any time the hardware accelerator generates an interrupt,

1 the data input program subroutine in the simulator transfers  
2 data from the input signal buffer to the associated RAM  
3 locations. Following the data transfer, a program subroutine  
4 checks if there are any changes between the newly loaded signals  
5 and the old data at the same memory locations. If there are no  
6 changes, no action is taken by the simulator, and the program  
7 subroutine waits for a new interrupt.

8 However, if the new data read from the target hardware is  
9 different from the previous data, then the subroutine will  
10 activate operation of the design simulator, which will process  
11 the newly received data, performing a simulation step. Next,  
12 another subroutine will monitor the simulator outputs to see if  
13 they have achieved a steady state. Once the outputs have  
14 achieved a steady state, another subroutine will start data  
15 transfer to the output buffer that will in turn start hardware  
16 accelerator operations.

17 The above and other objects, advantages, and novel features  
18 of the invention will be more fully understood from the  
19 following detailed description and the accompanying drawings, in  
20 which:

#### 21 BRIEF DESCRIPTION OF THE DRAWINGS

22 Figure 1 is a block diagram of a computer system running a  
23 design simulator and employing hardware accelerator.

24 Figure 2 is a flow diagram listing software subroutines for  
25 converting design files from ASIC applications to FPGA



1 implementations.

2 Figure 3 shows a typical ASIC design with two clock domains  
3 and race conditions.

4 Figure 4 shows a design with two clock domains converted  
5 into a single clock domain.

6 Figure 5 shows a design with a D-type flip-flops, two clock  
7 domains and race conditions.

8 Figure 6 shows a D flip-flop based design converted into a  
9 single clock domain.

10 Figure 7 is a diagram illustrating clock timing.

11 Figure 8 is a block diagram of a circuit design with  
12 latches and race conditions.

13 Figure 9 is a block diagram of a latch-based circuit design  
14 without race conditions.

15 Figure 10 is a block diagram illustrating another circuit  
16 design with latches and race conditions.

17 Figure 11 is a block diagram illustrating another circuit  
18 design with latches and race conditions.

19 Figure 12 is a block diagram illustrating the connectivity  
20 between hardware and software verification blocks.

21 Figure 13 is a block diagram illustrating a design being  
22 split into simulation and hardware acceleration files.

23 Figure 14 is a flow diagram illustrating the subroutines  
24 for data transfer between a simulator and a hardware  
25 accelerator.

## DETAILED DESCRIPTION OF THE PREFERRED EMBODIMENTS

A block diagram illustrating a computer system 1 for design verification and automatic ASIC prototyping by means of reprogrammable devices is illustrated in Figure 1. Computer system 1 can be a workstation such as a SunBlade 1000 manufactured by Sun Microsystems or a personal computer (PC) available from a number of manufacturers such as Dell, Hewlett-Packard, etc. Computer system 1 is comprised of processor 170, random access memory (RAM) 171, hard disk storage 172, data entry device 173 and display or monitor 180. While a variety of input devices or data entry devices can be used for simplicity, we will refer to data entry device 173 most frequently as a keyboard.

In addition, computer system 1 includes software simulator 4 residing in computer memory 171, a reprogrammable hardware accelerator 5 comprised of one or more reprogrammable devices that can be programmed with design sections, and Design Verification Manager (DVM) software 3 for converting ASIC designs to a format suitable for implementation in reprogrammable hardware accelerator 5. DVM software 3 can also be used to convert complex programmable logic device (CPLD) and FPGA designs made for one device family into designs operating on another CPLD or FPGA device family.

Simulator 4 can be any of the popular simulators such as a NC-Sim manufactured by Cadence Design, Inc. or Active-HDL

1 manufactured by Aldec, Inc. of Las Vegas, Nevada. Hardware  
2 accelerator 5 can be a hardware embedded simulation (HES)  
3 product made by Alatek Sp. z o.o. DVM 3 is a product offered by  
4 Alatek, Inc. and can be used for fitting HDL and netlist designs  
5 into field programmable devices such as a Virtex II manufactured  
6 by Xilinx, Inc. and Stratix manufactured by Altera, Inc.

7 Each ASIC design is comprised of design files 2. Design  
8 files 2 are fed into a set of software subroutines in DVM 3,  
9 which under the user control separates them into design files  
10 being processed by simulator 4 and hardware accelerator 5.  
11 Splitting design files subroutine 231 (Figure 13) is responsive  
12 to user inputs and divides ASIC design files 2 provided on  
13 signal line 230 into selected simulation files 233 and selected  
14 hardware execution files 235. Both selected simulation files  
15 233 and selected hardware execution file 235 are stored, via  
16 signal lines 232 and 234, respectively, in RAM memory 171.  
17 Selected simulation files 233 are sent over signal line 7 into  
18 software simulator 4 and selected hardware execution files 235  
19 are fed over signal line 10 into hardware accelerator 5.  
20 Typically, a user will send those design files that had fewer  
21 signal transitions and thus will simulate faster to simulator 4.  
22 On the other hand, design files 2 with a large number of signal  
23 transitions produced by a typical testbench stimuli file will be  
24 directed to hardware accelerator 5. Most software simulators 4  
25 such as Riviera from Aldec, Inc. and ModelSim from Mentor

1 Graphics, Inc. have "profiler" software that can scan designs  
2 and determine, which section of design files 2 has the most and  
3 least signal transitions.

4 To provide for direct interaction between selected  
5 simulation files 233 and selected hardware execution files 235,  
6 finding test points feeding data from simulator to hardware  
7 accelerator subroutine 237 and finding test points feeding data  
8 from hardware accelerator to simulator subroutine 241 analyze  
9 the design files 233 and 235, produced on signal lines 236 and  
10 240, and determine common signals or test points between them.  
11 Specifically, Finding Test Points Feeding Data from Simulator to  
12 Hardware Accelerator subroutine 237 determines which simulator 4  
13 test points should be feeding data into hardware accelerator 5.  
14 The list of these test points is fed over signal line 238 to  
15 selected hardware execution (SHA) database 239. Similarly,  
16 Finding Test Points Feeding Data from Hardware Accelerator to  
17 simulator subroutine 241 analyzes data produced on signal lines  
18 240, that includes selected simulation files 233 and selected  
19 hardware execution files 235, and produces a list of test points  
20 feeding data from hardware accelerator 5 outputs to simulator 4  
21 inputs. Finding Test Points Feeding Data from Hardware  
22 Accelerator to simulator subroutine 241 feeds the list of these  
23 test points over signal line 242 into selected hardware  
24 execution (HAS) database 243.

25 DVM 3 software uses SHA database 239 data to instruct

1 transferred data to temporary buffer subroutine 221 (Figure 14),  
2 which signals controlling hardware accelerator 5 should be  
3 transferred into temporary buffer 196 (Figure 12). Similarly,  
4 DVM 3 uses HAS database 243 to control the read input signal  
5 buffer subroutine 213 (Figure 14) and load the necessary signal  
6 data into simulator 4. Summarizing, after simulator 4 completes  
7 its internal operations, it outputs signals that stimulate  
8 hardware accelerator 5 operation. In return, once the hardware  
9 accelerator 5 operation achieves stable-state, it sends a signal  
10 that controls simulator 4 operations. This "ping-pong" like  
11 operation goes on until all test benches 181 (Figure 14) fed  
12 into simulator 4 via signal lines 182, DVM 3 and signal lines 7,  
13 or data on signal lines 208 feeding into target hardware 190  
14 (Figure 12) have been completed.

15 DVM software 3 is comprised of subroutines listed in the  
16 flow diagram of Figure 2. Find clocks software subroutine 11  
17 scans design files 2, provided on signal line 6, for design  
18 clocks, also called user clocks and sends their names and data  
19 over signal line 12 to find clocks database 13 (Database #1).  
20 Find clocks sources subroutine 15 receives pre-processed design  
21 files 2 on lines 14 that include a list of design clocks. Find  
22 clock sources subroutine 15 scans design files 2 for the sources  
23 of clocks provided on signal lines 14, and sends a list of the  
24 clock sources over signal line 16 to find clock sources database  
25 17 (Database #2). The list of clocks 13 and clock sources 17 is

1 also provided on line 18.

2 The invention is based on finding "clock sources" and  
3 "clock-dependent inputs", and applying to them the appropriate  
4 circuit transformations or algorithms. The clock source is a  
5 flip-flop or a latch that drives clock input pin of another  
6 latch or flip-flop. For example, flip-flop 82 in Figure 5 is a  
7 "clock source" because it generated a signal on signal line 93  
8 that feeds the clock input of flip-flop 81 via gate 84, signal  
9 line 95, gate 85 and signal line 97. Flip-flop 82 is also a  
10 "clock source" because it drives the synchronized D-input of  
11 flip-flop 83 via signal line 93, gate 84 and signal line 95.  
12 Primitives such as 84 and 85 that do not have clocked outputs  
13 are called asynchronous primitives. If such asynchronous  
14 primitives drive D or clock inputs of flip-flops, it may be a  
15 cause of unpredictable circuit behavior from one device layout  
16 to another. This invention eliminates the effects of  
17 asynchronous primitives in circuit operation.

18 Find clock subroutine 15 will find flip-flop 82 to be a  
19 "clock source" by analyzing synchronous inputs to flip-flops  
20 such as 81 and 83. Starting at the C-clock input to flip-flop  
21 81, find clock sources subroutine 15 traces signal line 97 to  
22 the output of gate 85. Next, find clock sources subroutine 15  
23 examines input to gate 85. By tracing signal line 95, find  
24 clock sources subroutine 15 locates gate 84. By analyzing  
25 signal line 93, connected to one of the inputs of gate 84, find

1 clock sources subroutine 15 finds flip-flop 82 and according to  
2 the definition employed and described hereinabove declares flip-  
3 flop 82 to be the "clock source".

4 The synchronous primitives with "clock-driven inputs" are  
5 flip-flops and latches that have their synchronous inputs such  
6 as D-input of flip-flop 83, connected to "clock source" signal  
7 line such as signal line 95, which was identified earlier by  
8 find clock sources subroutine 15 as being connected to a "clock  
9 source". Because of that, find synchronous primitives with  
10 clock-driven input subroutine 19 will identify primitive 83 as  
11 having a clock-driven input. Find Synchronous Primitives with  
12 Clock-Driven Inputs software subroutine 19 processes design data  
13 provided on signal line 18 and identifies primitives that have  
14 synchronous inputs such as preset, reset, enable, or data input  
15 connected in any way to a "clock source", and saves this data in  
16 find synchronous primitives database (Database #4) 184. In  
17 addition, find synchronous primitives database data is provided  
18 on lines 22, together with design file 2 data and find clocks  
19 database 13 and find clock sources database 17 information.

20 Find clock domains subroutine 23 analyzes data on signal  
21 lines 22 and groups all synchronous primitives by the associated  
22 clock-driven input signal lines. Groupings of primitives by the  
23 clock name such as signal line 97 or clock-related signal lines  
24 such as signal line 95 are called clock domains. Clock domains  
25 are provided on signal lines 181 to find clock domains database

1 (Database #4) 184. This grouping of related primitives is  
2 important because one edge detector will be enough to drive all  
3 primitives in the given clock domain.

4 In addition, find clock domain subroutine 23 separates  
5 positive-edge triggered primitives from negative-edge triggered  
6 primitives and provides them on signal lines 26 and 24,  
7 respectively.

8 The four databases 13, 17, 21, and 184 (#1-#4) are created  
9 for viewing by the designer, and can be displayed by computer 1  
10 on its display or monitor 180 under any of the available  
11 software such as Microsoft Word, Active-HDL and similar  
12 software.

13 Since for reliable operation all clocked primitives should  
14 trigger on the same clock edge, all negative edge triggered  
15 primitives must be converted to positive edge triggered  
16 primitives. Convert flip-flop to positive edge trigger  
17 subroutine 25 analyzes data on signal line 24 and substitutes  
18 positive-edge clocked primitives for negative edge clocked  
19 primitives. The list of new positive-edge clocked primitives is  
20 produced on signal line 27. A standardized design on negative-  
21 edge triggered primitives instead of positive-edged triggered  
22 primitives as specified above is fully within the scope of this  
23 invention.

24 Since all clock-driven inputs of clocked primitives must be  
25 stable prior to the main system clock's (MSC) positive



1 transition, insert separating flip-flop subroutine 28 adds a  
2 buffer or "separating" flip-flops on the inputs to such  
3 primitives. These buffer flip-flops, such as flip-flop 106 in  
4 Figure 6 are triggered prior to the system clock's positive  
5 transition. For example, they can be triggered on the negative  
6 edge of the MSC clock, as shown in Figure 7.

7 Preferably, clock sources, such as flip-flop 82, are  
8 controlled directly by the original user CLK clock, without  
9 applying any edge detectors. Because of that a buffer, such as  
10 flip-flop 106 is needed to stabilize the synchronized inputs to  
11 the primitives with clock-driven inputs such as primitive 83i.

12 The present invention is configured on the idea that the  
13 CLK user clocks, which have vastly different timings when ported  
14 from ASIC to FPGA devices, should not clock any synchronous  
15 primitives, except clock sources such as primitive 82. All CLK  
16 user clocks are used instead as clock enable (CE) signals for  
17 triggering primitives with the MSC signal 70 that has been  
18 developed for triggering all synchronous primitives in the  
19 entire design. To implement this concept replace all FF without  
20 CE with FF having CE scans data files provided on signal line 29  
21 and identifies which clock primitives do not have "clock enable"  
22 or CE inputs. Replace all flip-flops without CE with flip-flops  
23 having CE subroutine 30 will replace all such primitives with  
24 equivalent primitives but having a CE input. For example, the  
25 primitives 80, 81, and 83 in Figure 5 have been replaced with

1 flip-flops having CE by subroutine 30 with 80i, 81i, and 83i  
2 primitives, as shown in Figure 6.

3 To apply the user clock signals to the CE clock enable (CE)  
4 inputs, their transition must be detected by an "edge detector"  
5 such as edge detector circuit 79 in Figure 4, and then applied  
6 to the CE input. A detail description of the edge detector  
7 operation will be provided hereinafter with reference to Figure  
8 4.

9 Insert edge detectors and connect clocks to D-inputs  
10 subroutine 32 receives preprocessed design data on signal line  
11 31 and inserts "edge detectors" into the design so that the  
12 local or user clocks are applied to clock enable inputs of  
13 synchronous primitives instead of their clock inputs. MSC clock  
14 signal 70 is applied to the clock input of these synchronous  
15 primitives, such as 81i, so that all these primitives will be  
16 able to respond to the same rising, or falling, edge of MSC  
17 signal 70, being the system clock.

18 Connect all synchronous primitives to MSC clock subroutine  
19 34 connects MSC signal 70 to clock inputs of all clocked  
20 primitives provided on signal lines 33. Since the design still  
21 must respond to rising and falling edges of the local or user  
22 clocks, connect edge detectors outputs subroutine 36 responds to  
23 design data on signal line 35 and connects either the rising  
24 edge or falling edge of the local clock edge detector to the CE  
25 input of the selected primitive. For example, connect output

1 edge detectors output subroutine 36 (Figure 2) outputs this  
2 imposed design on signal lines 37 as the hardware embedded (HE)  
3 design file. The HE Design File is fed over signal line 37 to  
4 place and route software subroutine 38 such as ISE 5.1 from  
5 Xilinx, Inc. which produces a bit stream file for downloading  
6 the improved design over signal line 39, being now in a bit  
7 format, into FPGA device 40.

8 The following description is in reference to drawings that  
9 further clarify the operation of the DVM 3 subroutines listed in  
10 the flow diagram of Figure 2.

11 A design with two clock domains driven by the output signal  
12 lines 54 CLK clock and gate 44 is illustrated in Figure 3.  
13 Because gates 43 and 44 inject their own time delays, the  
14 triggering of primitive 42 may take place at an inappropriate  
15 time, creating a race condition. To eliminate this race  
16 condition, subroutines in the flow diagram of Figure 2 make a  
17 conversion of the circuit in Figure 3 into the circuit of Figure  
18 4. Find clocks subroutine 11 finds signal lines 50 and 54 to be  
19 clock signal lines. Find clock sources subroutine 15 identifies  
20 CLK terminal 47 as an external user clock signal and signal 54  
21 as the user clock produced by gate 44 directly from the external  
22 user clock on signal line 50. Since the user clock on signal  
23 line 50 is generated by gate 44 and not by a flip-flop, gate 44  
24 is not a "clock source" as defined hereinabove within the  
25 meaning of this invention because only flip-flops and latches

1 can be independent "clock sources".

2 By the definition employed in this invention, only "clock  
3 sources" can result in primitives with "clock-driven inputs".  
4 Since find clock sources subroutine 15 found no "clock sources"  
5 in Figure 3, no search for "clock-driven inputs" will be  
6 performed by find synchronous primitives subroutine 19.

7 Find clock domains subroutine 23 will find flip-flops 41,  
8 42 as being positive-edge triggered and that information will be  
9 sent on signal lines 26. No negative-edge triggered flip-flop  
10 data will be sent on signal line 24 because subroutine 23 found  
11 no such devices in design data (Figure 3) provided on signal  
12 line 22.

13 Find Clock Domains subroutine 23 will find that there are  
14 in Figure 3 two clocks driving inputs to synchronized  
15 primitives, thus we have two "clock domains": CLK clock  
16 provided on signal line 50 and signal line 54 being an output of  
17 gate 44. Should there be several pins connected to each clock  
18 signal line, such as signal lines 50 and 54, find clock domains  
19 subroutine 23 will list all primitives for each clock domain.  
20 Since all primitives in Figure 5 were positive edge triggered,  
21 there was no need to invoke convert flip-flop to positive edge  
22 trigger subroutine 25. Also, because all flip-flops in Figure 3  
23 have CE inputs, no replacements with CE type flip-flops have  
24 been performed by the replaced flip-flop subroutine 30.

25 Since find clock domains subroutine 23 identified

1 primitives 41 and 42 as synchronous primitives, insert edge  
2 detectors subroutine 32 will insert "edge detectors" 78 and 79  
3 on inputs, respectively. MSC signal line 70 will set "edge  
4 detector's" 79 flip-flop 67 with an output Q to a logical "0" at  
5 time t4 (Figure 7). After time t5, plus propagation delay of  
6 gates 43 and 44, gate 68 the output will be a logical "1"  
7 enabling the CE input of flip-flop 42 via AND gate 62. At time  
8 t6 MSC signal will trigger primitive 42 via signal line 70.  
9 Operation of edge detector 78 is similar to detector 79.

10 Connect all synchronous primitives to MSC clock subroutine  
11 34 has connected MSC signal line 70 to clock inputs of  
12 primitives 41 and 42, and a single clock line 70 is visible in  
13 Figure 4. Since primitives 41 and 42 were positive edge  
14 triggered flip-flops, connect edge detectors output subroutine  
15 36 has connected the rising edges 72 and 75 of edge detectors 78  
16 and 79, respectively, to the CE inputs of the corresponding  
17 synchronous primitives 41 and 42. Since primitives 41 and 42  
18 have been connected to CEA and CEB enable signals,  
19 respectively, AND gates 60 and 62 have been added to logically  
20 AND the CEA and CEB signals with rising Edge Signals 72 and 75,  
21 respectively. Figure 4 exemplifies how software subroutines in  
22 the flow diagram of Figure 2 have been used to process the  
23 design illustrated in Figure 3. The additional hardware in  
24 Figure 4, as compared to Figure 3, allows automatic elimination  
25 of clock skews and race conditions and saves months from the

1 design verification schedule.

2 Since synchronous primitives 80, 81, and 83 in Figure 5 do  
3 not have the CE inputs, replace all flip-flops subroutine 30 has  
4 replaced these primitives with 80i, 81i, and 83i, respectively,  
5 all having CE inputs, as shown in Figure 6. Because find clock  
6 sources subroutine 15 found clock source primitive 82, and  
7 primitive 83 had a race condition signal 95 connected to its D  
8 input, a "buffer" or separating flip-flop 106 has been added by  
9 insert separate flip-flops subroutine 28. Buffer 106 is  
10 triggered by negated MSC signal on signal line 70 so that D  
11 input of flip-flop 83i is stable by the time the positive-edge  
12 MSC signal on signal line 70 is applied.

13 If a flip-flop is a clock source primitive as in the case  
14 with flip-flop 82, no "edge detector" is needed for such a flip-  
15 flop 82.

16 Synchronous flip-flops respond to clock edges on their  
17 clock inputs while synchronous latches respond to voltage levels  
18 on their "gating" inputs. For all practical purposes, the gate  
19 enable (GE) input of a latch behave similarly to the CE input of  
20 a flip-flop and the gate (G) input of a latch behaves similar to  
21 a flip-flop's clock input. For this reason, the DVM 3 software  
22 processes similarly the flip-flops and latches. Figure 2  
23 software subroutines 11, 15, 19, 23, 24, 25, 28, and 30 operate  
24 similarly on flip-flops and on latches.

25 The circuit design in Figure 8 illustrates a circuit with

1 two latches 110 and 111. Since the latches do not have gating  
2 enable GE inputs, they are converted by replace all flip-flops  
3 subroutine 30 into latches with GE inputs 110i and 111i,  
4 respectively. Because latches are sensitive to voltage levels  
5 on their "gating" (clocking) inputs, insert edge detectors  
6 subroutine 32 inserts enable inverter 131 for latch 110i and  
7 another enable inverter 132 for latch 111i. Inverter enables  
8 131 and 132 are triggered in Figure 8 by voltage levels.  
9 Otherwise, they operate similarly to edge enable in Figure 4.

10 Sometimes there can be two or more latches connected  
11 serially, all of them being clock sources, as shown in Figure  
12 10. Such latches 141 and 142 should be treated as independent  
13 clock sources and shall be driven with their original signal  
14 line 150, as shown in Figure 11. For this reason, final clock  
15 sources subroutine 15 does not stop at the first found latch 141  
16 but checks if latch 142 does not have on its input yet another  
17 latch driver such as 141. Since latches 141 and 142 are clock  
18 drivers, they should not have on their inputs neither enable  
19 inverters, such as enable inverter 131, nor buffer latches such  
20 as buffer latch 164. It is very important that latches 141 and  
21 142 be driven directly by the original input signals and produce  
22 their output signals at the earliest possible time.

23 After DVM 3 processes ASIC design files 2, it downloads  
24 selected design sections into simulator 4 via signal lines 7 for  
25 software simulation of their functional behavior. The selected

1 design sections could actually reside in the same memory  
2 locations, which were occupied by ASIC Design Files 2 but the  
3 addressing and control over those memory locations is passed  
4 from DVM 3 to software subroutines located in simulator 4. To  
5 underscore the direct control of simulator 4 over those selected  
6 design sections, simulator design memory 200 has been added in  
7 Figure 1. Simulator 4 exerts its control over simulated design  
8 sections, stored in simulator design logical memory 200, via  
9 signal lines 207. Simulator design logical memory 200 may be  
10 comprised of numerous locations in physical memory or RAM 171.

11 Using automatic ASIC into FPGA netlist conversion  
12 procedures described hereinabove, DVM 3 downloads via signal  
13 lines 10 the remaining design sections into the hardware  
14 accelerator 5, and specifically into target hardware 190, being  
15 preferably an FPGA. Signal lines 7 and 10 are used for  
16 downloading of selected design sections of design file 2 into  
17 simulator 4 and hardware accelerator 5, and for applying signal  
18 stimuli such as test benches 181.

19 Test benches 181 are typically developed by users through  
20 keyboard 173 entries and stored on hard disk 172 via signal line  
21 179, processor 170 and signal line 178. For faster operations,  
22 test benches are typically saved in local RAM and then applied  
23 to simulator 4 and hardware accelerator 5. For this reason,  
24 test benches 181 are downloaded into memory from hard disk 172  
25 via signal line 178, processor 170, signal line 175, DVM 3



1 software subroutines controlling RAM 171 download operations on  
2 signal line 182. When directed by keyboard 173 entry or DVM 3  
3 subroutine command, test bench signals are read via signal line  
4 182 and applied via signal line 176, processor 170 and signal  
5 line 174 to simulator 4 and hardware accelerator 5. It needs to  
6 be noted that signal lines 7 and 10 can be implemented by a  
7 combination of signal lines 176, processor 170 and signal lines  
8 174.

9 The hardware acceleration process, using simulator 4 and  
10 hardware accelerator 5 and their associated signal lines and  
11 software subroutines has been described in detail in U.S. Patent  
12 No. 5,479,355 of Hyduke, issued December 26, 1995, and  
13 incorporated herein by reference made hereto to the disclosure.  
14 Also, the operation of a software simulator has been described  
15 in detail in U.S. Patent No. 5,051,938 of Hyduke, issued  
16 September 24, 1991, and incorporated herein by reference, and  
17 therefore no detailed explanation of software simulator 4  
18 operations is necessary. The nomenclature used in the  
19 aforementioned two patents is also applicable here.

20 The aforementioned selected design sections that have been  
21 downloaded into simulator design 200 logical memory are shown in  
22 greater detail in Figure 12. since the design sections may be  
23 located at different areas of RAM 171, they are shown as  
24 simulator design circuits #1 through #i.

25 After the design sections have been loaded into simulator 4

and hardware accelerator 5, stimuli signals representing external signal events are applied either to the simulator 4 or hardware accelerator 5. For example, if simulator 4 simulates an UART device, then any signal received on the UART's input will stimulate the entire design comprised of design sections located in simulator 4 and hardware accelerator 5, because of interconnecting signal lines 8a through 8i and 9a through 9n. Similarly, if a USB device located in hardware accelerator 5 receives a data file over its input lines, it will trigger some operations in hardware accelerator 5 and then through signal lines 8a through 8i and 9a through 9n may cause a series of data exchanges between simulator 4 and accelerator 5 design blocks.

Since hardware accelerator 5 operates at very high clock speeds and simulator 4 operates at relatively slow software clock speeds, a synchronization of events in both hardware and software environments needs to be provided. Figure 12 illustrates the distinct handling of signals flowing from simulator 4 to accelerator 5 and vice versa.

At the heart of hardware accelerator 5 is programmable target hardware 190 that stores the selected design sections that have been downloaded by DVM 3 into the hardware accelerator 5 via signal lines 10. All signals 193a through 193i that are applied to target hardware 190 must be applied at the same time because if these signals 193a through 193i are applied in a random order then random operation of target hardware will

1 result. For this reason, when simulator 4 completes a  
2 simulation cycle and downloads its outputs to hardware  
3 accelerator 5, it does it in two steps. First, a series of  
4 bytes or words of data is loaded over numerous clock cycles into  
5 a "temporary buffer" 196. These words of data are stored in  
6 buffer 196 under control of a signal generated on signal line  
7 202 by a software subroutine residing in simulator 4 and  
8 controlling data transfer from simulator 4 to buffer 196.

9 When all signals for hardware accelerator 5 are updated and  
10 present in buffer 196, a simulator 4 software subroutine that  
11 controls data transfer to hardware accelerator 5 issues a signal  
12 on signal line 203 that transfers data from temporary buffer 196  
13 into driver buffer 194. This transfer should be accomplished in  
14 minimum time and with minimum time "skew" between channels.  
15 Typically, the skew will be on the order of one to a few  
16 nanoseconds.

17 The design sections in hardware accelerator 5 respond very  
18 fast to all signal transitions on its inputs, such as those  
19 presented on signal lines 193a through 193i. Typically, target  
20 hardware 190 will produce stable signals on its output signal  
21 lines 197a through 197n within a few nanoseconds after it has  
22 received new signals on signal lines 193a through 193i. This  
23 means that if hardware accelerator 5 does not include any  
24 microprocessors or delay lines, simulator 4 can read output  
25 signals 197a through 197n on its first software clock cycle

1 after issuing a signal on signal line 203. Since place and  
2 route software subroutine 38 in Figure 2 can calculate the  
3 longest path delay in target hardware 190, it can provide an  
4 advisory for simulator 4 after which time the subroutine  
5 hardware timeout 211 should read the new data provided by target  
6 hardware 190 on signal lines 197a through 197n. This time can  
7 be determined in terms of simulator 4 clock periods.

8         However, if the target hardware 190 includes a  
9 microprocessor, timers or delay lines, read detector 205 needs  
10 to be implemented. Each time a processor completes the required  
11 operations, each time a delay time is complete or each time a  
12 timer times out, a signal is produced by target hardware 190 on  
13 signal line 204 and read detector 205 generates an interrupt  
14 signal on signal line 206 that is read by simulator 4. In  
15 response to the interrupt signal on signal line 206, simulator 4  
16 reads data from input signal buffer 191. Since the data on  
17 signal lines 197a through 197n is stable during reading by  
18 simulator 4, the input signal buffer 191 can be a multiplexer  
19 that selectively chooses under simulator 4 control of various  
20 test points in target hardware 5.

21         The closed loop operation of design blocks in simulator 4  
22 and hardware accelerator 5 are described now in reference to  
23 Figures 13 and 14. Figure 13 illustrates software subroutines  
24 residing in DVM 3 and associated with the setup of the closed  
25 loop operation between the simulator 4 and accelerator 5.

1 Software subroutine "splitting design files" 231 operates under  
2 user control and divides ASIC design files 2 into a file to be  
3 simulated by the software simulator and another one that  
4 includes design blocks for execution in hardware. Subroutine  
5 "splitting design files" 231 provides the selected for  
6 simulation files, called "selected simulation" file, into  
7 database "selected for simulation" 233, residing preferably in  
8 RAM 171, via signal line 232. Subroutine "splitting design  
9 files" 231 saves, via signal line 234, chosen for hardware  
10 implementation design files into selected hardware execution  
11 file database 235, residing preferably in RAM 171. The  
12 information in selected simulation file database 233 is provided  
13 to simulator via signal line 7. The information in selected  
14 hardware execution file database 235 is processed further by DVM  
15 3 subroutines listed in Figure 2.

16 Subroutine 237 analyzes information on signal line 236 that  
17 provides data on what is being placed in simulator 4 and what  
18 will be downloaded into hardware accelerator 5 and identifies  
19 which simulator 4 output signals will be driving hardware  
20 accelerator input signal lines. This information is stored via  
21 signal lines 238 in SHA database 239, being preferably in RAM  
22 171 and being available to simulator 4 subroutines. Simulator 4  
23 software subroutines will use this information for configuring  
24 data being sent for simulator 4 to "output signal temporary  
25 buffers" 196 and driver buffer 194.

1           Finding test points feeding data from hardware accelerator  
2 to simulator subroutine 241 identifies test points in simulator  
3 4 that will be receiving input signals from hardware accelerator  
4 5 output signal lines. This information is stored via signal  
5 lines 242 in HAS database 243, which is residing preferably in  
6 RAM 171. The information in HAS database 243 is used for  
7 feeding signal lines to "input signal buffer" 191 and for  
8 configuring signal arrangement in the buffer 191.

9           The closed loop arrangement of design blocks residing in  
10 simulator 4 and hardware accelerator 5 can be stimulated into  
11 activity either by signals appearing on signal line 191 of the  
12 target hardware (Figure 12) or on signal lines 182 driven by  
13 "test benches" database 181. If the stimuli signal appears on  
14 input signal lines 189 to target hardware 190, then target  
15 hardware 190 emulates the new input conditions and produces  
16 output signals on signal line 209. If target hardware 190  
17 includes a microprocessor, then an interrupt will be generated  
18 by interrupt or hardware timeout subroutine 211, which can be a  
19 hardware implementation, software implementation or combination  
20 of both. Similarly, if target hardware 190 has some timers or  
21 delay lines, interrupt or hardware timeout subroutine 211 will  
22 generate a signal on signal lines 212 when they terminate their  
23 operation. If the target hardware does not have processor,  
24 timers or delay lines, it is preferred that interrupt or  
25 hardware timeout subroutine 211 downloads into register 191

1 signals for controlling simulator 4 inputs, and generates a  
2 signal on signal lines 212 within one or a few hardware clock  
3 cycles upon receiving data on signal lines 190. Signals on  
4 signal lines 212 inform simulator 4 that it can read data from  
5 "input signal buffer" 191.

6 "Read input signal buffer" 213 is a software subroutine  
7 within simulator 4 for reading data from buffer 191 and saving  
8 this data at appropriate locations in RAM 171, being under  
9 simulator 4 control. Upon completion of this operation, it  
10 issues a signal on signal line 214. Responding to data on  
11 signal line 214, any changes in input signals subroutine 215  
12 checks if the new input signal data differs from previous inputs  
13 to simulator 4. If there is a difference a simulation cycle  
14 will be performed. If there was no difference on input signal  
15 lines provided by buffer 191, simulator 4 does not perform any  
16 simulation and awaits another set of inputs from hardware device  
17 228 that will feed new hardware signals on signal lines 189 into  
18 target hardware 190.

19 If simulator 4 performed a simulation cycle by simulate  
20 design subroutine 217, it will provide simulation data on signal  
21 lines 218 and is data on signal lines stable subroutine 219 will  
22 check for simulation completion. Upon completion of the  
23 simulation cycle, is data on signal lines stable subroutine 219  
24 will issue an output that will control data transfer to  
25 temporary buffer 196. The data transfers should preferably be

1 made in 32 or 64 bit words, compatible with computer 1 internal  
2 bus structure. All signals transferred subroutine 223 monitors  
3 words transferred to output signal temporary buffer 196 on  
4 signal lines 222 and when the last data word has been sent to  
5 the output signal temporary buffer 196, the all signals  
6 transferred subroutine 223 issues a command on signal line 224  
7 to transfer data from temporary buffer 196 to output signal  
8 driver buffer 194 that directly controls the target hardware.  
9 Transfer data to driver buffer subroutine 225 generates a signal  
10 on signal line 203 that actually performs downloading of data  
11 from output signal temporary buffers 196 to output signal driver  
12 buffer 196.

13 If the arrangement of simulator 4 with hardware accelerator  
14 5 is stimulated by test bench signals 181 provided on signal  
15 lines 182, then simulate design subroutine 217 will perform one  
16 design simulation cycle. Is data on signal lines stable  
17 subroutine 219 monitors signal lines 218 to determine when the  
18 simulation cycle is complete and issues a signal on signal line  
19 220 when the simulation data is stable and ready to feed into  
20 target hardware 190. Thereafter, the cycle described above  
21 repeats itself.

22 This invention is not to be limited by the embodiment shown  
23 in the drawings and described in the description which is given  
24 by way of example and not of limitation, but only in accordance  
25 with the scope of the appended claims.